



Type SKS 15

basic @ level

Conductive one-staff-level probe with welding sleeve system and modular process connection

Advanced Features

- ▶ Welding sleeve system with modular process connection
- ▶ Aseptic measuring point possible
- ▶ Electrodes free cuttable
- ▶ Wettingparts made of high-grade steel
Mat. No. 1.4404 / HALAR® 3404DA - coating
- ▶ FDA, EHEDG-conformal

Technical features

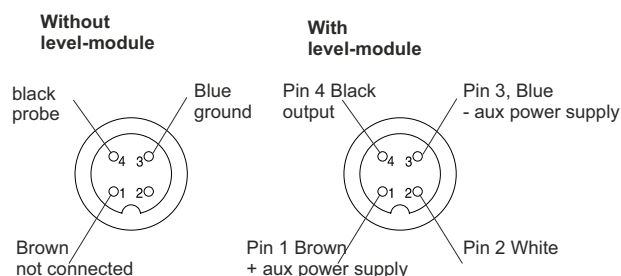
- ▶ Electrodes blank or coated *
- ▶ Optional high-grade-steel connecting head
Material No. 1.4305
- ▶ Optional deliverable with level module
- ▶ With connecting head optional connections:
 - Screw joint
 - M12 plug
- ▶ Without connecting head optional connections:
 - M12 plug
 - hard coded cable
- ▶ Thread G 1/2 " elastomerfree sealing system
- ▶ Safety class IP69K
- ▶ CiP/SiP Cleaning 140°C, 30 min.
- ▶ ambient temperature: -10...60°C
- ▶ permissible media temperature: 0...100°C
- ▶ staff length 2mtr. max.



Favoured fields of application are e.g.:

- ▶ Low- / high alarm in containers
- ▶ Media registration in pipes as pump protection
- ▶ Container filling / deflation with level control

M12 Plug



*Coating for SIP applications
(Sterilizing-In-Place) only conditionally suitable.

SKS 15 - [] - [] - []

High-grade steel connecting head

With connecting head and with screw joint	0	5
With connecting head and with M12-plug	0	6
Without connecting head with M12-plug	1	1
Without connecting head with fixed cable	1	X

Probe length

Standard length blank staff Ø 4 mm, 4 mm	4-A
Standard length blank staff Ø 4 mm, 200 mm	200-A
Standard length coated staff Ø 4 mm, 200 mm	200-B
Standard length coated staff Ø 4 mm, 500 mm	500-B
Standard length coated staff Ø 4 mm, 1000 mm	1000-B
Standard length coated staff Ø 4 mm, 2000 mm	2000-B
Probelength coated staff Ø 10mm	x-F
Customized, price of the next larger standard length + 18€ cutting costs	K

Level modul

optional with integrated level modul
1 x Break Resistance 100 kOhm

SNKM
DB

Please note that during installation and removal of coated probes, the coating is not damaged. Damage can lead to errors in the evaluation!